

LSU308 N-CHANNEL JFET



Linear Systems replaces discontinued Siliconix U308

The LSU308 is a high frequency n-channel JFET offering a wide range and low noise performance. The hermetically sealed TO-18 package is well suited for high reliability and harsh environment applications.

(See Packaging Information).

LSU308 Benefits:

- High Power Low Noise gain
- Dynamic Range greater than 100dB
- Easily matched to 75Ω input

LSU308 Applications:

- UHV / VHF Amplifiers
- Mixers
- Oscillators

FEATURES				
DIRECT REPLACEMENT FOR SILICONIX U308				
OUTSTANDING HIGH FREQUENCY GAIN	$G_{pg} = 11.5dB$			
LOW HIGH FREQUENCY NOISE	NF = 2.7dB			
ABSOLUTE MAXIMUM RATINGS @ 25°C ¹				
Maximum Temperatures				
Storage Temperature	-55°C to +150°C			
Operating Junction Temperature	-55°C to +135°C			
Maximum Power Dissipation				
Continuous Power Dissipation	500mW			
MAXIMUM CURRENT	*			
Gate Current	10mA >			
MAXIMUM VOLTAGES	5			
Gate to Drain Voltage or Gate to Source Voltage	-25V			

LSU308 ELECTRICAL CHARACTERISTICS @ 25°C (unless otherwise noted)

SYMBOL	CHARACTERISTIC	MIN	TYP.	MAX	UNIT	CONDITIONS
BV_{GSS}	Gate to Source Breakdown Voltage	-25			V	$V_{DS} = 0V$, $I_{G} = -1\mu A$
$V_{GS(F)}$	Gate to Source Forward Voltage	0.7		1		$V_{DS} = 0V$, $I_G = 10mA$
$V_{GS(off)}$	Gate to Source Cutoff Voltage	-1		-6.5		$V_{DS} = 10V, I_{D} = 1nA$
I _{DSS}	Drain to Source Saturation Current ²	12		60	mA	$V_{DS} = 10V, V_{GS} = 0V$
I _G	Gate Operating Current (Note 3)		-15		pА	$V_{DG} = 9V, I_{D} = 10mA$
r _{DS(on)}	Drain to Source On Resistance		35		Ω	$V_{GS} = 0V$, $I_D = 1mA$

LSU308 DYNAMIC ELECTRICAL CHARACTERISTICS @ 25°C (unless otherwise noted)

SYMBOL	CHARACTERISTIC		MIN	TYP.	MAX	U <mark>NI</mark> T	CONDITIONS
g fs	Forward Transconductance		8	14		mS	$V_{DS} = 10V$, $I_{D} = 10mA$, $f = 1kHz$
g _{os}	Output Conductance		1	110	2 <mark>50</mark>	μS	
C _{iss}	Input Capacitance		1	4	5	pF	$V_{DS} = 10V$, $V_{GS} = -10V$, $f = 1MHz$
C_{rss}	Reverse Transfer Capacitance	,	-	1.9	2.5		
e _n	Equivalent Noise Voltage		6			nV/√Hz	$V_{DS} = 10V$, $I_{D} = 10$ mA, $f = 100$ Hz

LSU308 HIGH FREQUENCY CHARACTERISTICS @ 25°C (unless otherwise noted)

SYMBOL	CHARACTERISTIC		MIN	TYP	MAX	UNIT	CONDITIONS
NF	Noise Figure	f = 105MHz		1.5		dB	
		f = 450MHz		2.7		dB	
G _{pg}	Power Gain ³	f = 105MHz		16			
		f = 450MHz		11.5			
g _{fg}	Forward Transconductance	f = 105MHz		14			$V_{DS} = 10V$, $I_D = 10$ mA
		f = 450MHz		13		6	
g_{og}	Output Conductance	f = 105MHz		0.16		mS	
		f = 450MHz		0.55		1	

Note 1 - Absolute maximum ratings are limiting values above which LSU308 serviceability may be impaired.

Note 2 - Pulse test : PW \leq 300 μ s, Duty Cycle \leq 3% Note 3 - Measured at optimum input noise match

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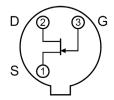
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Email: chipcomponents@micross.com Web: http://www.micross.com/distribution Available Packages:

LSU308 in TO-18 LSU308 in bare die.

Please contact Micross for full package and die dimensions

TO-18 (Bottom View)



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